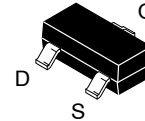# N-Channel RF Amplifier

MMBF5484, MMBF5485, MMBF5486

This device is designed primarily for electronic switching applications such as low On Resistance analog switching. Sourced from Process 50.

NOTE: Source & Drain are interchangeable

SOT–23
CASE 318–08

ABSOLUTE MAXIMUM RATINGS* (T_A = 25°C unless otherwise noted)

Symbol	Rating	Value	Unit
V_{DG}	Drain–Gate Voltage	25	V
V_{GS}	Gate–Source Voltage	−25	V
I_{GF}	Forward Gate Current	10	mA
T_J, T_{stg}	Operating and Storage Junction Temperature Range	−55 to +150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.
*These rating are limiting values above which the serviceability of any semiconductor device may be impaired.
1. These rating are based on a maximum junction temperature of 150°C.
2. These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.

THERMAL CHARACTERISTICS (T_A = 25°C unless otherwise noted)

Symbol	Characteristic	Max *MMBF5484–5486	Unit
P_D	Total Device Dissipation Derate above 25°C	225 1.8	mW mW/°C
$R_{\theta JC}$	Thermal Resistance, Junction to Case	–	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	556	°C/W

*Device mounted on FR−4 PCB 1.6" x 1.6" x 0.06".

MARKING DIAGRAM
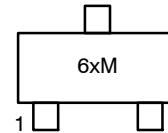
6x   = Device Code (x = B, M, H)
M   = Date Code

ORDERING INFORMATION

Device	Package	Shipping†
MMBF5484	SOT−23 (Pb−Free)	3000 Tape & Reel
MMBF5484		
MMBF5484		

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

MMBF5484, MMBF5485, MMBF5486

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Symbol	Parameter	Test Condition		Min	Typ	Max	Unit
OFF CHARACTERISTICS							
$V_{(BR)GSS}$	Gate−Source Breakdown Voltage	$I_G = -1.0~\mu A$, $V_{DS} = 0$		−25	–	–	V
I_{GSS}	Gate Reverse Current	$V_{GS} = -20$ V, $V_{DS} = 0$ $V_{GS} = -20$ V, $V_{DS} = 0$, $T_A = 100°C$		– –	– –	−1.0 −0.2	nA μA
$V_{GS(off)}$	Gate−Source Cutoff Voltage	$V_{DS} = 15$ V, $I_D = 10$ nA	*5484* *5485* *5486*	−0.3 −0.5 −2.0	– – –	−3.0 −4.0 −6.0	V V V
ON CHARACTERISTICS							
I_{DSS}	Zero−Gate Voltage Drain Current*	$V_{DS} = 15$ V, $V_{GS} = 0$	*5484* *5485* *5486*	1.0 4.0 8.0	– – –	5.0 10 20	mA mA mA
SMALL SIGNAL CHARACTERISTICS							
g_{fs}	Forward Transfer Conductance	$V_{DS} = 15$ V, $V_{GS} = 0$, f = 1.0 kHz	*5484* *5485* *5486*	3000 3500 4000	– – –	6000 7000 8000	μmhos μmhos μmhos
$Re_{(y_{is})}$	Input Conductance	$V_{DS} = 15$ V, $V_{GS} = 0$, f = 100 MHz	*5484*	–	–	100	μmhos
		$V_{DS} = 15$ V, $V_{GS} = 0$, f = 400 kHz	*5485 / 5486*	–	–	1000	μmhos
g_{os}	Output Conductance	$V_{DS} = 15$ V, $V_{GS} = 0$, f = 1.0 kHz	*5484* *5485* *5486*	– – –	– – –	50 60 75	μmhos μmhos μmhos
$Re_{(y_{os})}$	Output Conductance	$V_{DS} = 15$ V, $V_{GS} = 0$, f = 100 MHz	*5484*	–	–	75	μmhos
		$V_{DS} = 15$ V, $V_{GS} = 0$, f = 400 MHz	*5485 / 5486*	–	–	100	μmhos
$Re_{(y_{fs})}$	Forward Transconductance	$V_{DS} = 15$ V, $V_{GS} = 0$, f = 100 MHz	*5484*	2500	–	–	μmhos
		$V_{DS} = 15$ V, $V_{GS} = 0$, f = 400 MHz	*5485* *5486*	3000 3500	– –	– –	μmhos μmhos
C_{iss}	Input Capacitance	$V_{DS} = 15$ V, $V_{GS} = 0$, f = 1.0 MHz		–	–	5.0	pF
C_{rss}	Reverse Transfer Capacitance	$V_{DS} = 15$ V, $V_{GS} = 0$, f = 1.0 MHz		–	–	1.0	pF
C_{oss}	Output Capacitance	$V_{DS} = 15$ V, $V_{GS} = 0$, f = 1.0 MHz		–	–	2.0	pF
NF	Noise Figure	$V_{DS} = 15$ V, $R_G = 1.0~k\Omega$, f = 100 MHz	*5484*	–	–	3.0	dB
		$V_{DS} = 15$ V, $R_G = 1.0~k\Omega$, f = 400 MHz	*5484*	–	4.0	–	dB
		$V_{DS} = 15$ V, $R_G = 1.0~k\Omega$, f = 100 MHz	*5485 / 5486*	–	–	2.0	dB
		$V_{DS} = 15$ V, $R_G = 1.0~k\Omega$, f = 400 MHz	*5485 / 5486*	–	–	4.0	dB

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.
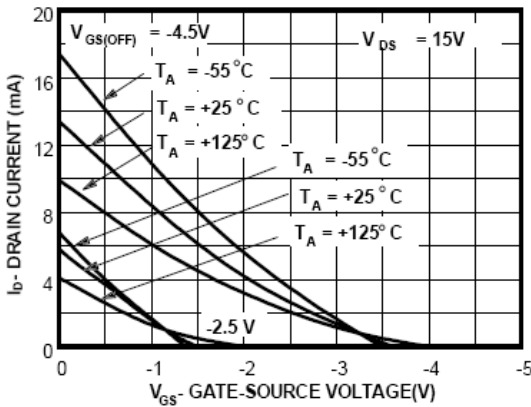
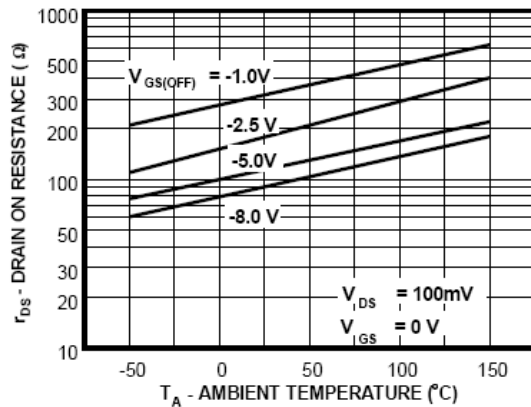## TYPICAL CHARACTERISTICS

Figure 1. Transfer Characteristics
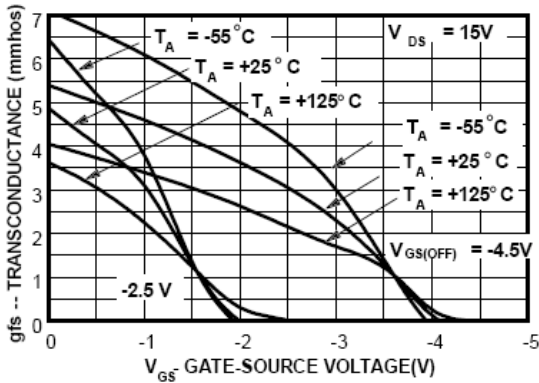
Figure 2. Channel Resistance vs. Temperature

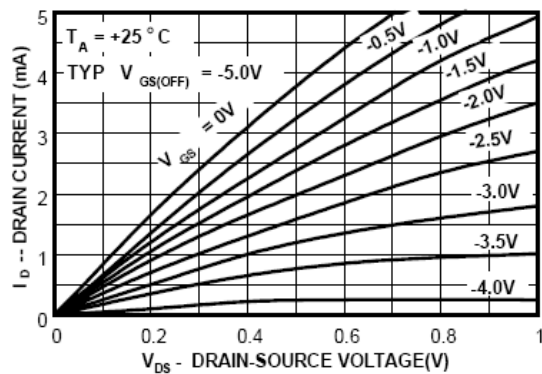**Figure 3. Transconductance Characteristics**
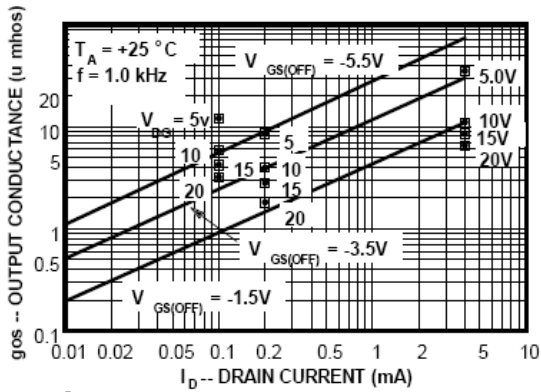
Figure 4. Common Drain−Source Characteristics
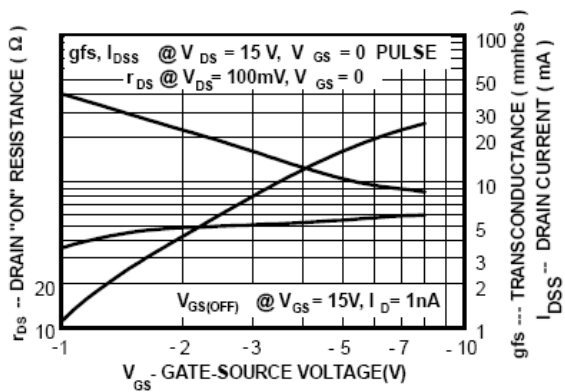
Figure 5. Output Conductance vs. Drain Current

Figure 6. Transconductance Parameter Interactions
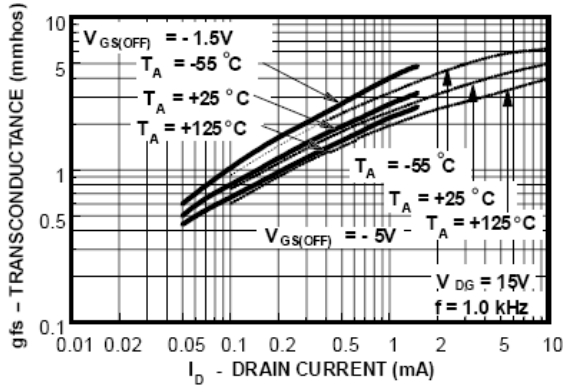
TYPICAL CHARACTERISTICS (continued)
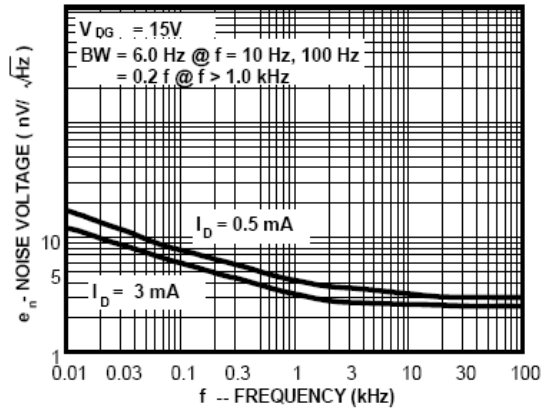
Figure 7. Transconductance vs. Drain Current
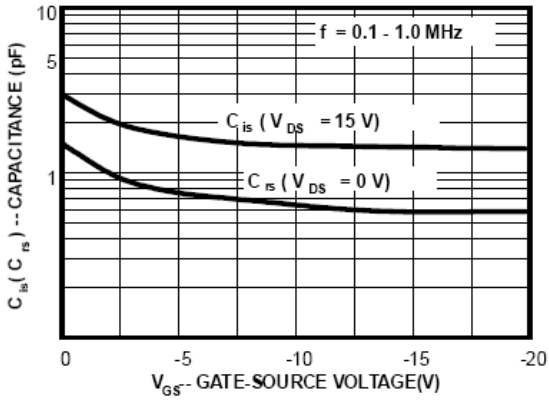
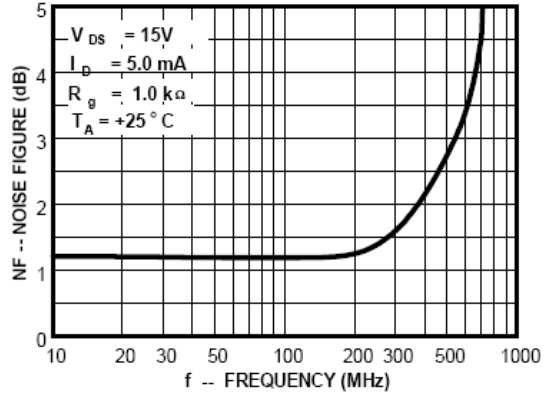Figure 8. Noise Voltage vs. Frequency

Figure 9. Capacitance vs. Voltage

Figure 10. Noise Figure Frequency

COMMON SOURCE CHARACTERISTICS
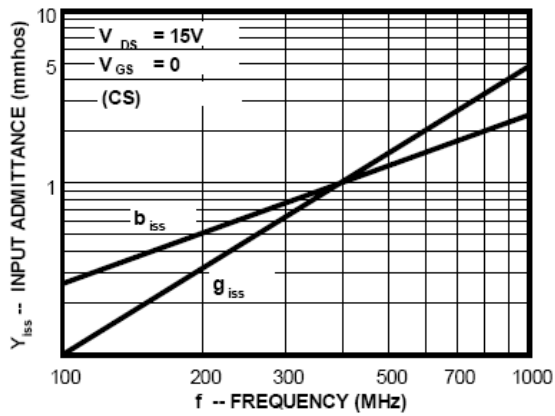
Figure 11. Input Admittance
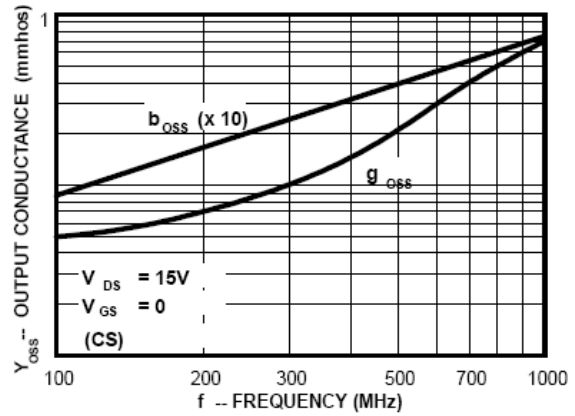
Figure 12. Output Admittance
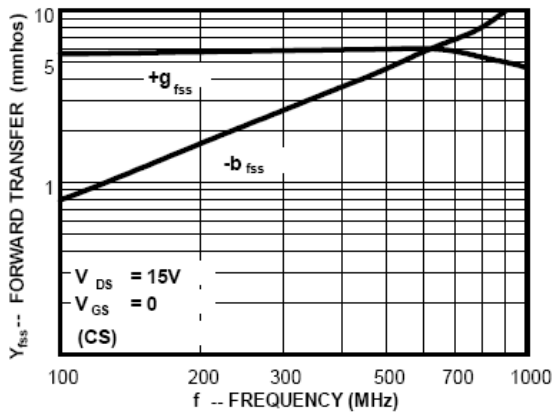
Figure 13. Forward Transadmittance
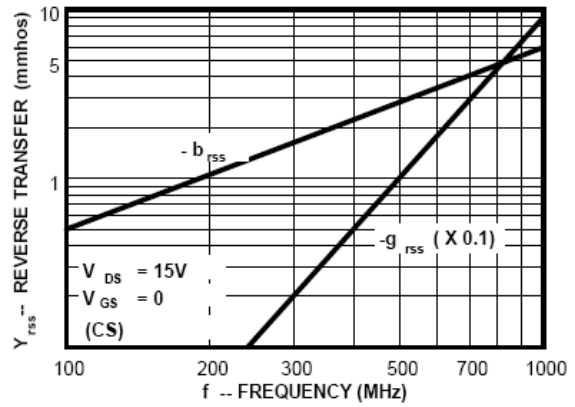
Figure 14. Reverse Transadmittance

COMMON GATE CHARACTERISTICS
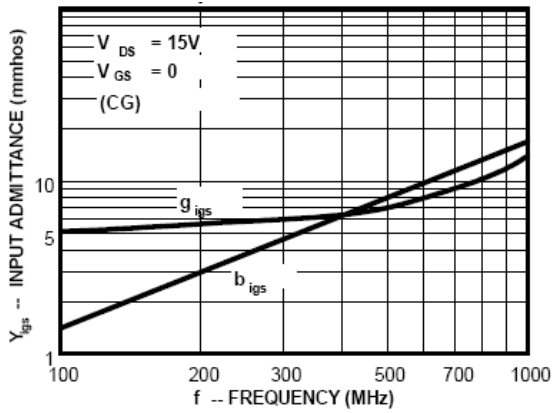
Figure 15. Input Admittance
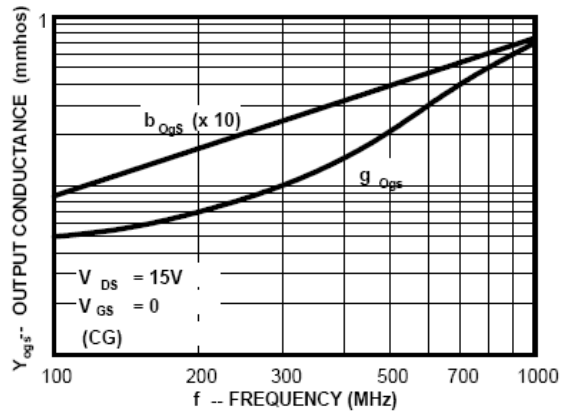
Figure 16. Output Admittance
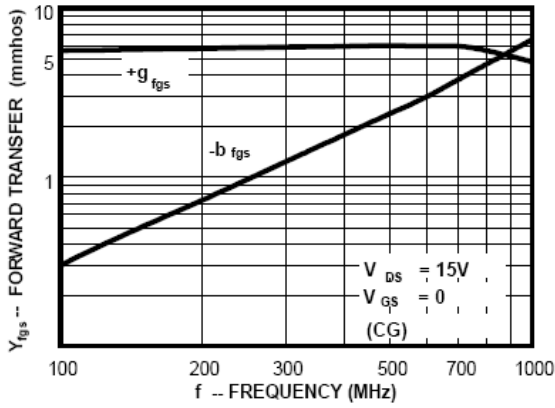
Figure 17. Forward Transadmittance
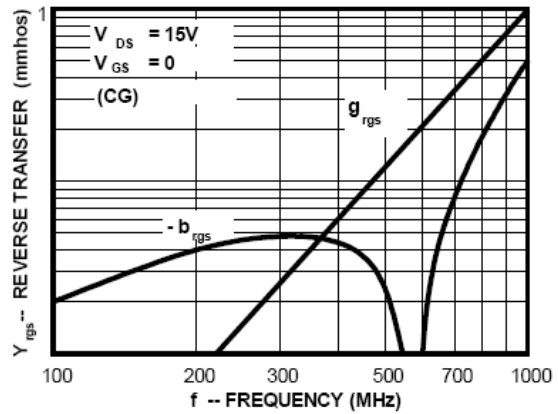
Figure 18. Reverse Transadmittance

MECHANICAL CASE OUTLINE
PACKAGE DIMENSIONS

SOT−23 (TO−236)
CASE 318−08
ISSUE AS

DATE 30 JAN 2018

SCALE 4:1

TOP VIEW

VIEW C

SIDE VIEW

END VIEW

SEE VIEW C

RECOMMENDED
SOLDERING FOOTPRINT

DIMENSIONS: MILLIMETERS

NOTES:
1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: MILLIMETERS.
3. MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF THE BASE MATERIAL.
4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.

DIM	MILLIMETERS			INCHES		
	MIN	NOM	MAX	MIN	NOM	MAX
A	0.89	1.00	1.11	0.035	0.039	0.044
A1	0.01	0.06	0.10	0.000	0.002	0.004
b	0.37	0.44	0.50	0.015	0.017	0.020
c	0.08	0.14	0.20	0.003	0.006	0.008
D	2.80	2.90	3.04	0.110	0.114	0.120
E	1.20	1.30	1.40	0.047	0.051	0.055
e	1.78	1.90	2.04	0.070	0.075	0.080
L	0.30	0.43	0.55	0.012	0.017	0.022
L1	0.35	0.54	0.69	0.014	0.021	0.027
H$_E$	2.10	2.40	2.64	0.083	0.094	0.104
T	0°	–––	10°	0°	–––	10°

GENERIC
MARKING DIAGRAM*

XXXM■
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1

XXX = Specific Device Code
M   = Date Code
■   = Pb−Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb−Free indicator, "G" or microdot " ■", may or may not be present.

STYLE 1 THRU 5:
CANCELLED

STYLE 6:
PIN 1. BASE
    2. EMITTER
    3. COLLECTOR

STYLE 7:
PIN 1. EMITTER
    2. BASE
    3. COLLECTOR

STYLE 8:
PIN 1. ANODE
    2. NO CONNECTION
    3. CATHODE

STYLE 9:
PIN 1. ANODE
    2. ANODE
    3. CATHODE

STYLE 10:
PIN 1. DRAIN
    2. SOURCE
    3. GATE

STYLE 11:
PIN 1. ANODE
    2. CATHODE
    3. CATHODE−ANODE

STYLE 12:
PIN 1. CATHODE
    2. CATHODE
    3. ANODE

STYLE 13:
PIN 1. SOURCE
    2. DRAIN
    3. GATE

STYLE 14:
PIN 1. CATHODE
    2. GATE
    3. ANODE

STYLE 15:
PIN 1. GATE
    2. CATHODE
    3. ANODE

STYLE 16:
PIN 1. ANODE
    2. CATHODE
    3. CATHODE

STYLE 17:
PIN 1. NO CONNECTION
    2. ANODE
    3. CATHODE

STYLE 18:
PIN 1. NO CONNECTION
    2. CATHODE
    3. ANODE

STYLE 19:
PIN 1. CATHODE
    2. ANODE
    3. CATHODE−ANODE

STYLE 20:
PIN 1. CATHODE
    2. ANODE
    3. GATE

STYLE 21:
PIN 1. GATE
    2. SOURCE
    3. DRAIN

STYLE 22:
PIN 1. RETURN
    2. OUTPUT
    3. INPUT

STYLE 23:
PIN 1. ANODE
    2. ANODE
    3. CATHODE

STYLE 24:
PIN 1. GATE
    2. DRAIN
    3. SOURCE

STYLE 25:
PIN 1. ANODE
    2. CATHODE
    3. GATE

STYLE 26:
PIN 1. CATHODE
    2. ANODE
    3. NO CONNECTION

STYLE 27:
PIN 1. CATHODE
    2. CATHODE
    3. CATHODE

STYLE 28:
PIN 1. ANODE
    2. ANODE
    3. ANODE

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DESCRIPTION:	SOT−23 (TO−236)	PAGE 1 OF 1

PUBLICATION ORDERING INFORMATION

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